

<b>Notice of References Cited</b>	Application/Control No. 09/856,796	Applicant(s)/Patent Under Reexamination HIRSCH ET AL.	
	Examiner Brandon J Fetterolf, PhD	Art Unit 1642	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0068690 A1	06-2002	BALDWIN et al.	514/1
	B	US-5,725,851	03-1998	Wong et al.	424/85.2
	C	US-			
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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